## TOSHIBA TRANSISTOR SILICON NPN EPITAXIAL PLANAR TYPE

# 2 S C 4 3 9 4

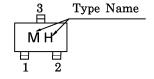
VHF~UHF BAND LOW NOISE AMPLIFIER APPLICATIONS

- Low Noise Figure, High Cain.
- NF = 1.1dB,  $|S_{21e}|^2 = 11dB$  (f=1GHz)

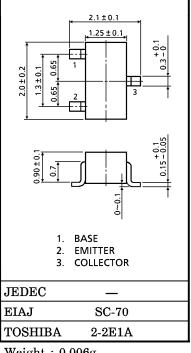
#### MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Collector-Base Voltage	$v_{CBO}$	20	V
Collector-Emitter Voltage	$v_{CEO}$	12	V
Emitter-Base Voltage	$V_{ m EBO}$	3	V
Collector Current	$I_{\mathbf{C}}$	80	mA
Base Current	$I_{\mathbf{B}}$	40	mA
Collector Power Dissipation	PC	100	mW
Junction Temperature	$T_{j}$	125	°C
Storage Temperature Range	$T_{ m stg}$	-55~125	°C

### Marking







Weight: 0.006g

## MICROWAVE CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Transition Frequency	$ m f_{T}$	$V_{CE}=10V, I_{C}=20mA$	5	7	_	GHz
Incortion (Join	$ S_{21e} ^2$ (1)	$V_{CE} = 10V, I_{C} = 20mA, f = 500MHz$	_	16.5	_	dB
	$ S_{21e} ^2$ (2)	$V_{CE}=10V$ , $I_{C}=20mA$ , $f=1GHz$	7.5	11	_	ub
Noise Figure	NF (1)	$V_{CE}=10V$ , $I_{C}=5mA$ , $f=500MHz$	_	1	_	dB
	NF (2)	$V_{CE}=10V$ , $I_{C}=5mA$ , $f=1GHz$	_	1.1	2	լահ

#### ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-off Current	ICBO	$V_{CB} = 10V, I_{E} = 0$	_	_	1	$\mu$ A
Emitter Cut-off Current	$I_{EBO}$	$V_{EB}=1V, I_{C}=0$	_	_	1	$\mu$ A
DC Current Gain	$h_{ extbf{FE}}$	$V_{CE}=10V, I_{C}=20mA$	30	_	250	_
Output Capacitance	$C_{ob}$	$V_{CB} = 10V, I_E = 0, f = 1MHz$	_	1.0	_	pF
Reverse Transfer Capacitance	$\mathrm{C_{re}}$	(Note)	_	0.7	1.15	pF

# (Note) Cre is measured by 3 terminal method with capacitance bridge.

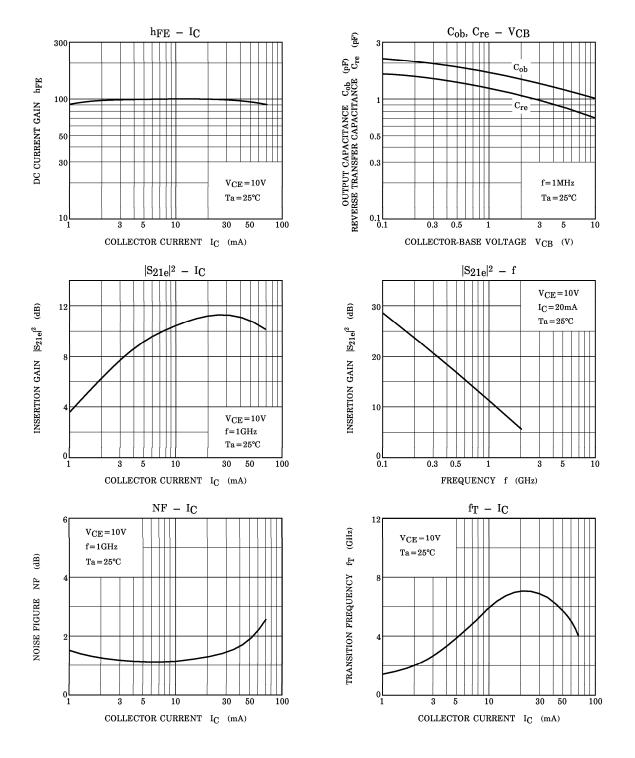
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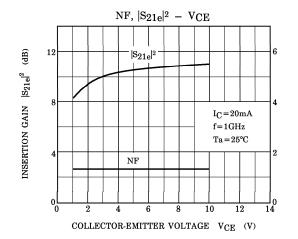
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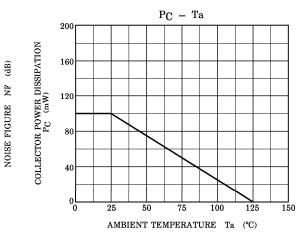
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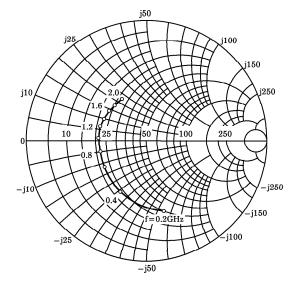


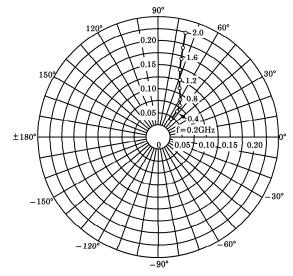






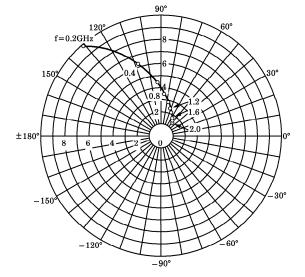


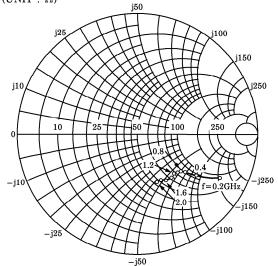






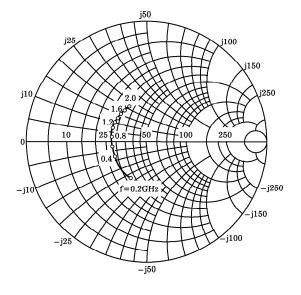


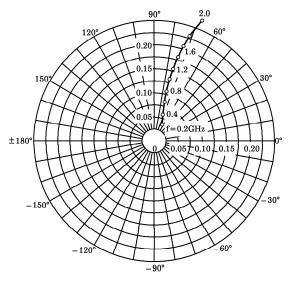












 $\begin{array}{l} S_{21e} \\ V_{CE} \! = \! 10V \\ I_{C} \! = \! 20mA \\ Ta \! = \! 25^{\circ}C \end{array}$ 

